SN74CBTS6800 10-BIT FET BUS SWITCH WITH PRECHARGED OUTPUTS AND SCHOTTKY DIODE CLAMPING SCDS102B – JUNE 1999 – REVISED MAY 2000

- 5-Ω Switch Connection Between Two Ports
- TTL-Compatible Input Levels
- Outputs Are Precharged by Bias Voltage to Minimize Signal Distortion During Live Insertion
- Schottky Diodes on the I/Os to Clamp Undershoots up to -2 V
- Package Options Include Plastic Shrink Small-Outline (DB, DBQ), Thin Very Small-Outline (DGV), Small-Outline (DW), and Thin Shrink Small-Outline (PW) Packages

DB, DBQ, DGV, DW, OR PW PACKAGE (TOP VIEW)								
ON (1	24	V _{CC}					
A1 (2	23	B1					
A2 (3	22	B2					
A3 (4	21	B3					
A4 (5	20	B4					
A5 (6	19	B5					
A6 (7	18	B6					
A7 (8	17	B7					
A8 (9	16	B8					
A9 (10	15	B9					
A10 (11	14	B10					
GND (12	13	BIASV					

description

The SN74CBTS6800 provides ten bits of high-speed TTL-compatible bus switching with Schottky diodes on the I/Os to clamp undershoot.

The low on-state resistance of the switch allows bidirectional connections to be made, while adding near-zero propagation delay. The device also precharges the B port to a user-selectable bias voltage (BIASV) to minimize live-insertion noise.

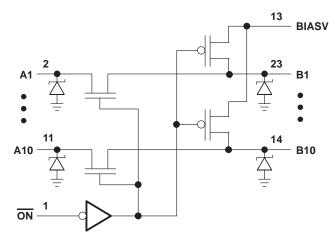
The SN74CBTS6800 is organized as one 10-bit switch with a single enable (\overline{ON}) input. When \overline{ON} is low, the switch is on, and port A is connected to port B. When \overline{ON} is high, the switch between port A and port B is open. When \overline{ON} is high or V_{CC} is 0 V, B port is precharged to BIASV through the equivalent of a 10-k Ω resistor.

The SN74CBTS6800 is characterized for operation from -40°C to 85°C.

FUNCTION TABLE

ON	B1–B10	FUNCTION
L	A1–A10	Connect
Н	BIASV	Precharge

logic diagram (positive logic)





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SN74CBTS6800 10-BIT FET BUS SWITCH WITH PRECHARGED OUTPUTS AND SCHOTTKY DIODE CLAMPING

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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)[†]

Bias voltage range, BIASV Input voltage range, V _I (see Note 1) Continuous channel current Input clamp current, I _{IK} (V _I < 0) Package thermal impedance, θ_{JA} (see Note 2): DB DB DG DW PW	-0.5 V to 7 V -0.5 V to 7 V -0.5 V to 7 V -0.5 V to 7 V 128 mA -50 mA package 63°C/W Q package 61°C/W V package 86°C/W / package 88°C/W
Storage temperature range, T _{stg}	–65°C to 150°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input and output negative-voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

2. The package thermal impedance is calculated in accordance with JESD 51.

recommended operating conditions (see Note 3)

		MIN	MAX	UNIT
VCC	Supply voltage	4	5.5	V
BIASV	Supply voltage	1.3	VCC	V
VIH	High-level control input voltage	2		V
VIL	Low-level control input voltage		0.8	V
Τ _Α	Operating free-air temperature	-40	85	°C

NOTE 3: All unused control inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, *Implications of Slow or Floating CMOS Inputs*, literature number SCBA004.

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PAI	RAMETER		TEST CONDITI	ONS	MIN	TYP‡	MAX	UNIT
VIK	A or B inputs	V _{CC} = 4.5 V,	l: 10 m ∧				-0.7	V
	Control inputs		lı = –18 mA				-1.2	v
۱ _{IL}		V _{CC} = 5.5 V,	V _I = GND				-5	μA
IIH		V _{CC} = 5.5 V,	V _I = 5.5 V				150	μA
lo		V _{CC} = 4.5 V,	BIASV = 2.4 V,	V _O = 0	0.25			mA
ICC		V _{CC} = 5.5 V,	$I_{O} = 0,$	$V_I = V_{CC}$ or GND			3	μA
∆ICC§	Control inputs	V _{CC} = 5.5 V,	One input at 3.4 V,	Other inputs at V_{CC} or GND			2.5	mA
Ci	Control inputs	VI = 3 V or 0				3.5		pF
C _{io(OFF}	·)	V _O = 3 V or 0,	$\overline{ON} = V_{CC}$			4.5		pF
ron¶		$V_{CC} = 4 V$, TYP at $V_{CC} = 4 V$	V _I = 2.4 V,	lj = 15 mA		11	20	
				I _I = 64 mA		3	7	Ω
		$V_{CC} = 4.5 V$	$V_{I} = 0$	lı = 30 mA		3	7	
			V _I = 2.4 V,	l _l = 15 mA		6	15	

[‡] All typical values are at $V_{CC} = 5 V$ (unless otherwise noted), $T_A = 25^{\circ}C$.

§ This is the increase in supply current for each input that is at the specified TTL voltage level rather than V_{CC} or GND.

¶ Measured by the voltage drop between the A and B terminals at the indicated current through the switch. On-state resistance is determined by the lower of the voltages of the two (A or B) terminals.



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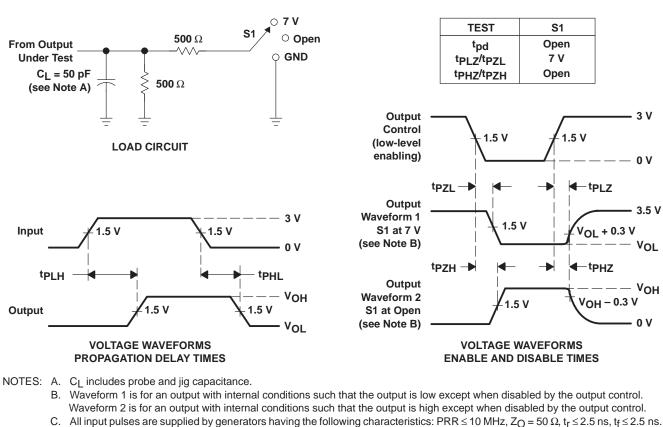
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switching characteristics over recommended operating free-air temperature range, CL = 50 pF (unless otherwise noted) (see Figure 1)

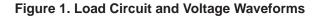
PARAMETER	TEST CONDITIONS	FROM (INPUT)		V _{CC} = 4 V	V _{CC} = 5 V ± 0.5 V		UNIT
			(001101)	MIN MAX	MIN	MAX	
tpd [†]		A or B	B or A	0.35		0.25	ns
^t PZH	BIASV = GND	ŌN	A or B	6	2	5.1	20
^t PZL	BIASV = 3 V		AUB	6	2	5.6	ns
^t PHZ	BIASV = GND	ŌN	A or P	5.5	1	5	
^t PLZ	BIASV = 3 V		A or B	5.5	2	5.9	ns

[†] The propagation delay is the calculated RC time constant of the typical on-state resistance of the switch and the specified load capacitance, when driven by an ideal voltage source (zero output impedance).

PARAMETER MEASUREMENT INFORMATION



- D. The outputs are measured one at a time with one transition per measurement.
- E. tpLz and tpHz are the same as tdis.
- F. tpzL and tpzH are the same as ten.
- G. tpLH and tpHL are the same as tpd.





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